

Title (en)

QUARTZ GLASS COMPONENT WITH REFLECTOR LAYER AND METHOD FOR PRODUCING THE SAME

Title (de)

QUARZGLAS-BAUTEIL MIT REFLEKTORSCHICHT SOWIE VERFAHREN ZUR HERSTELLUNG DESSELBEN

Title (fr)

COMPOSANT EN VERRE QUARTZEUX À COUCHE RÉFLÉCHISSANTE ET SON PROCÉDÉ DE FABRICATION

Publication

EP 2102125 A1 20090923 (DE)

Application

EP 07857521 A 20071213

Priority

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- DE 102006062166 A 20061222

Abstract (en)

[origin: US2009316268A1] Methods for producing a quartz glass component with reflector layer are known in which a reflector layer composed of quartz glass acting as a diffuse reflector is produced on at least part of the surface of a substrate body composed of quartz glass. In order, taking this as a departure point, to specify a method which enables cost-effective and reproducible production of uniform SiO₂ reflector layers on quartz glass components, it is proposed according to the invention that the reflector layer is produced by thermal spraying by means of SiO₂ particles being fed to an energy carrier, being incipiently melted or melted by means of said energy carrier and being deposited on the substrate body. In the case of a quartz glass component obtained according to the method, the SiO₂ reflector layer is formed as a layer which is produced by thermal spraying and has an opaque effect and which is distinguished by freedom from cracks and uniformity.

IPC 8 full level

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CPC (source: EP KR US)

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Citation (search report)

See references of WO 2008077807A1

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